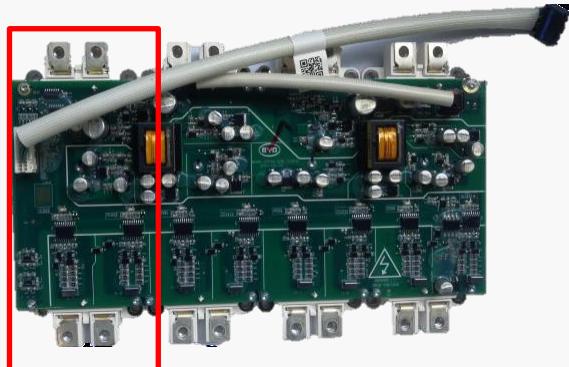


SEMIKRON SEMIX604GB12T4s IGBT POWER MODULE STRUCTURE ANALYSIS REPORT – Product used in BYD's SONG EV500

Spring contact



Power module



Power module after resin removal

Product outline

- The Model Song EV500 SUV has a mileage range od 400km/charge
- **Basic features**
- SEMIKRON's IGBT module is used in the motor control inverter
- Spring contact control terminals create solder-free connection
- The maximum rated voltage is 1,200V and the maximum collector current is 916A
- **Report contents**
- In the module analysis cross-section and EDX analysis of the spring contacts, die attach, and key components are performed.
- Plane and cross-section analysis of the cell area and die edge were performed in order to determine what type of IGBT technology is used by the Chinese manufacturer. The device was analyzed to determine how it was optimized to support the breakdown voltage specification.
- The thermal resistance is estimated from the dimensions of the module and the results of material analysis.

Note: The report price may change over time. For current price contact info@ltecusa.com.

19G-0023-3

Table of Contents

	Page
<u>Device summary</u>	3
<u>Analysis summary</u>	4
Table 2: Device structure (IGBT)	5
Table 3: Device structure (Material & thickness)	6
Table 4: Module structure	7
<u>Module analysis</u>	
Overview	8
IGBT die image	15
Cross section	16
<u>IGBT structure analysis</u>	
Plane view observation (OM)	36
Plane view observation (SEM)	56
Cross section	64
<u>Appendix</u>	
Thermal resistance modeling	77
Heat sink analysis modeling: Effective heat transfer convection coefficient h_{eff}	78
Comparison between Fuji electric module and Hitachi module	81

19G-0023-3

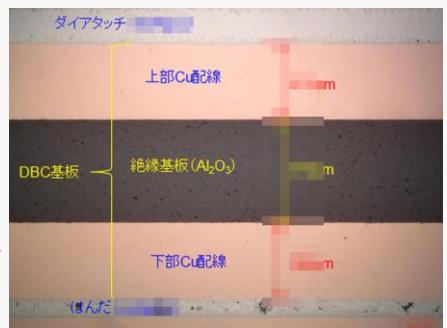
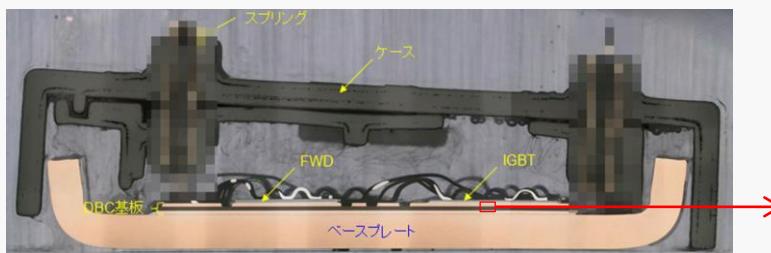


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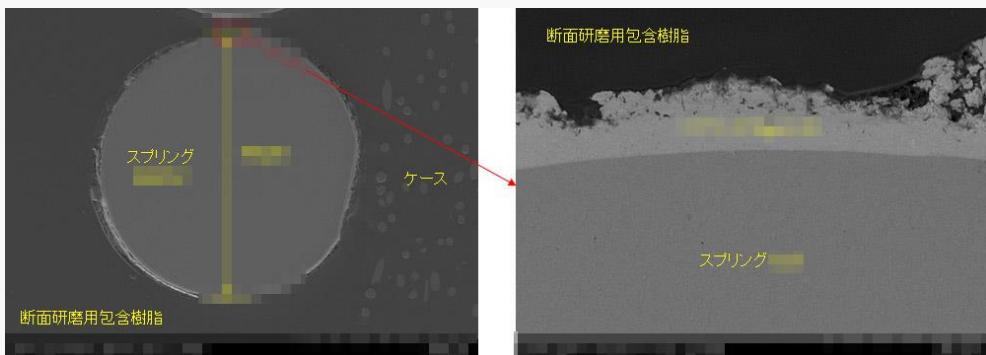
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Excerpts from the analysis report

Module cross section



Spring contact cross section



Thermal analysis

IGBT

Device	SEMIKRON IGBT Half-Bridge Power Module	
	SEMIX 5045B12T4s	Power Module
Package		
		Case 1: Nominal
Semiconductor Die IGBT	Device	IGBT
	Material	LTEC評価
	Thickness, d [μm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
	Mass density, δ [g/cm^3]	材料特性
	Number of Transistors	
	Size, X [mm]	LTEC評価
	Size, Y [mm]	LTEC評価
	Die size, X×Y [mm ²]	LTEC評価
Die Attach	Material	[未記載]
	Thickness, d [μm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
DBC (top)	Material	LTEC評価
	Thickness, d [mm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
	Thermal Diffusivity, D [cm^2/s]	材料特性
Insulated substrate	Material	LTEC評価
	Thickness, d [mm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
DBC (Bottom)	Material	LTEC評価
	Thickness, d [mm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
	Thermal Diffusivity, D [cm^2/s]	材料特性
+Total DBC Thickness		[mm]
DBC-Base Plate Solder	Material	LTEC評価
	Thickness, d [μm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
Base Plate	Material	LTEC評価
	Thickness, d [mm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
	Thermal Diffusivity, D [cm^2/s]	材料特性
(1) Semi-Die Thermal Resistance		[°C/W]
(2) Die Attach Thermal Resistance		[°C/W]
? DBC Thermal resistance		[°C/W]
? DBC-BasePlate Solder Thermal resistance		[°C/W]
(3) Base Plate Thermal resistance		[°C/W]
(4) Bottom Path Thermal resistance per Transistor		[°C/W]
(5) Switch Thermal Resistance, Rth(jc)		[°C/W]
Total Thermal Resistance, Rth(jc) (Datasheet)		[°C/W] 0.049 (MAX)
	モデル計算値	
	データシート値	

FWD

Device	SEMIKRON IGBT Half-Bridge Power Module	
	SEMIX 5045B12T4s	Power Module
Package		
		Case 1: Nominal
Semiconductor Die FWD	Device	Diode
	Material	LTEC評価
	Thickness, d [μm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
	Mass density, δ [g/cm^3]	材料特性
	Number of Transistors	
	Size, X [mm]	LTEC評価
	Size, Y [mm]	LTEC評価
	Die size, X×Y [mm ²]	LTEC評価
Die Attach	Material	[未記載]
	Thickness, d [μm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
DBC (top)	Material	LTEC評価
	Thickness, d [mm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
	Thermal Diffusivity, D [cm^2/s]	材料特性
Insulated substrate	Material	LTEC評価
	Thickness, d [mm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
DBC (Bottom)	Material	LTEC評価
	Thickness, d [mm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
	Thermal Diffusivity, D [cm^2/s]	材料特性
+Total DBC Thickness		[mm]
DBC-Base Plate Solder	Material	LTEC評価
	Thickness, d [μm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
Base Plate	Material	LTEC評価
	Thickness, d [mm]	LTEC評価
	Thermal Conductivity [$W/cm \cdot K$]	材料特性
	Thermal Diffusivity, D [cm^2/s]	材料特性
(1) Semi-Die Thermal Resistance		[°C/W]
(2) Die Attach Thermal Resistance		[°C/W]
? DBC Thermal resistance		[°C/W]
? DBC-BasePlate Solder Thermal resistance		[°C/W]
(3) Base Plate Thermal resistance		[°C/W]
(4) Bottom Path Thermal resistance per Transistor		[°C/W]
(5) Switch Thermal Resistance, Rth(jc)		[°C/W]
Total Thermal Resistance, Rth(jc) (Datasheet)		[°C/W] 0.088 (MAX)
	モデル計算値	
	データシート値	

19G-0023-3